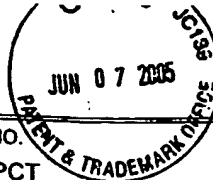
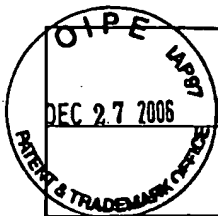


Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 259727US0X PCT		SERIAL NO. 508945 New U.S. PCT Application Based on PCT/JP03/03700	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Sumie SUDA, et al.		FILING DATE Herewith	
				GROUP 1742			
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
07	AA	5904787	05/18/99	MATSUMOTO, Sadamu et al.			
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
07	AO	11-246941	09/14/99	JP(with English Abstract)			NO
	AP	7-188852	07/25/95	JP(with English Abstract)			NO
	AQ	7-136933	05/30/95	JP(with English Abstract)			NO
	AR	614994	09/14/94	EP			NO
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						
Examiner <i>Deborah Lee</i>					<input type="checkbox"/> Additional References sheet(s) attached Date Considered <i>2-9-07</i>		

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 259727US0XPCT		SERIAL NO. 10/508,945	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Sumie SUDA, et al.			
				FILING DATE October 1, 2004		GROUP 1742	
				U.S. PATENT DOCUMENTS			
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
DY	AA	6,224,686 B1	05/01/2001	Toshinori AOKI, et al.			
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
DY	AO	8-120407	05/14/1996	JAPAN (with English Abstract)			X
	AP	0 462 779 A2	12/27/1991	EUROPE			
	AQ	11-6033	01/12/1999	JAPAN (with English Abstract)			X
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
DY	AW	DATABASE INSPEC Online, AN-6739795, XP-002318429, September 30, 2000					
	AX	Won Jong NAM, et al., "Effects of alloy additions and tempering temperature on the sag resistance of Si-Cr spring steels", Materials Science and Engineering A, vol. A289, no. 1-2, XP-002318428, September 30, 2000, pages 8-17					
	AY						
	AZ						<input type="checkbox"/> Additional References sheet(s) attached
Examiner Deborah Yee				Date Considered 1-9-07			
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							



	Docket No.: 259727US0X PCT	Serial No.: 10/508,945
LIST OF RELATED CASES CITED BY APPLICANT UNDER 37 CFR 1.56	Inventor: Sumie SUDA, et al.	
	Filing Date: October 1, 2004	Group: 1742

**LIST OF RELATED CASES**

Examiner <u>Initial</u>	<u>Docket No.</u>	Serial or <u>Patent</u> <u>Number</u>	Filing or <u>Issue Date</u>	Patent App. <u>Publication No.</u>	Inventor or <u>Applicant</u>
DT	296926US0	11/538,703	10/04/06		YOSHIHARA
DT	259727US0XPCT*	10/508,945	10/01/04	US2005/0173028 A1	SUDA, et al.
DT	297253US0	11/548,080	10/10/06		YOSHIHARA, et al.

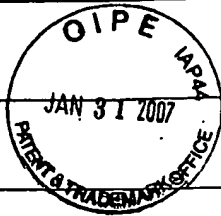
Examiner

Date Considered

Deborah Yee

2-9-07

\*Present Application; listed for information  
NFO/ach/kch



Docket No.: 259727US0X PCT

Serial No.: 10/508,945

Inventor: Sumie SUDA, et al.

LIST OF RELATED CASES CITED BY  
APPLICANT UNDER 37 CFR 1.56

Filing Date: October 1, 2004

Group: 1742

**LIST OF RELATED CASES**

Examiner <u>Initial</u>	<u>Docket No.</u>	Serial or <u>Patent</u> <u>Number</u>	Filing or <u>Issue Date</u>	Patent App. <u>Publication No.</u>	Inventor or <u>Applicant</u>
0Y	299019US0	11/559,654	11/14/06		YOSHIHARA
0Y	259727US0XPCT*	10/508,945	10/01/04	US2005/0173028 A1	SUDA, et al.

Examiner

Date Considered

Deborah Yee

2-9-07

\*Present Application; listed for information  
NFO/ach